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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

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Stratix Device Handbook, Volume 1



101 Innovation Drive San Jose, CA 95134 (408) 544-7000 http://www.altera.com

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formation and before placing orders for products or services.

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Chapter Revision Dates

The chapters in this book, *Stratix Device Handbook*, *Volume 1*, were revised on the following dates. Where chapters or groups of chapters are available separately, part numbers are listed.

Chapter 1. Introduction

Revised: July 2005 Part number: S51001-3.2

Chapter 2. Stratix Architecture

Revised: July 2005 Part number: S51002-3.2

Chapter 3. Configuration & Testing

Revised: July 2005 Part number: S51003-1.3

Chapter 4. DC & Switching Characteristics

Revised: January 2006 Part number: S51004-3.4

Chapter 5. Reference & Ordering Information

Revised: September 2004 Part number: S51005-2.1

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About This Handbook

This handbook provides comprehensive information about the Altera® Stratix family of devices.

How to Find Information

You can find more information in the following ways:

- The Adobe Acrobat Find feature, which searches the text of a PDF document. Click the binoculars toolbar icon to open the Find dialog box.
- Acrobat bookmarks, which serve as an additional table of contents in PDF documents.
- Thumbnail icons, which provide miniature previews of each page, provide a link to the pages.
- Numerous links, shown in green text, which allow you to jump to related information.

How to Contact Altera

For the most up-to-date information about Altera products, go to the Altera world-wide web site at www.altera.com. For technical support on this product, go to www.altera.com/mysupport. For additional information about Altera products, consult the sources shown below.

Information Type	USA & Canada	All Other Locations
Technical support	www.altera.com/mysupport/	www.altera.com/mysupport/
	(800) 800-EPLD (3753) (7:00 a.m. to 5:00 p.m. Pacific Time)	+1 408-544-8767 7:00 a.m. to 5:00 p.m. (GMT -8:00) Pacific Time
Product literature	www.altera.com	www.altera.com
Altera literature services	literature@altera.com	literature@altera.com
Non-technical customer service	(800) 767-3753	+ 1 408-544-7000 7:00 a.m. to 5:00 p.m. (GMT -8:00) Pacific Time
FTP site	ftp.altera.com	ftp.altera.com

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Typographic Conventions

This document uses the typographic conventions shown below.

Visual Cue	Meaning
Bold Type with Initial Capital Letters	Command names, dialog box titles, checkbox options, and dialog box options are shown in bold, initial capital letters. Example: Save As dialog box.
bold type	External timing parameters, directory names, project names, disk drive names, filenames, filename extensions, and software utility names are shown in bold type. Examples: f _{MAX} , \qdesigns directory, d: drive, chiptrip.gdf file.
Italic Type with Initial Capital Letters	Document titles are shown in italic type with initial capital letters. Example: AN 75: High-Speed Board Designs.
Italic type	Internal timing parameters and variables are shown in italic type. Examples: t_{PIA} , $n+1$.
	Variable names are enclosed in angle brackets (< >) and shown in italic type. Example: <file name="">, <pre><pre><pre><pre><pre><pre>pof</pre> file.</pre></pre></pre></pre></pre></file>
Initial Capital Letters	Keyboard keys and menu names are shown with initial capital letters. Examples: Delete key, the Options menu.
"Subheading Title"	References to sections within a document and titles of on-line help topics are shown in quotation marks. Example: "Typographic Conventions."
Courier type	Signal and port names are shown in lowercase Courier type. Examples: $\mathtt{data1}$, \mathtt{tdi} , \mathtt{input} . Active-low signals are denoted by suffix \mathtt{n} , $\mathtt{e.g.}$, \mathtt{resetn} .
	Anything that must be typed exactly as it appears is shown in Courier type. For example: c:\qdesigns\tutorial\chiptrip.gdf. Also, sections of an actual file, such as a Report File, references to parts of files (e.g., the AHDL keyword SUBDESIGN), as well as logic function names (e.g., TRI) are shown in Courier.
1., 2., 3., and a., b., c., etc.	Numbered steps are used in a list of items when the sequence of the items is important, such as the steps listed in a procedure.
•••	Bullets are used in a list of items when the sequence of the items is not important.
✓	The checkmark indicates a procedure that consists of one step only.
	The hand points to information that requires special attention.
4	The angled arrow indicates you should press the Enter key.
	The feet direct you to more information on a particular topic.

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Section I. Stratix Device Family Data Sheet

This section provides the data sheet specifications for Stratix[®] devices. They contain feature definitions of the internal architecture, configuration and JTAG boundary-scan testing information, DC operating conditions, AC timing parameters, a reference to power consumption, and ordering information for Stratix devices.

This section contains the following chapters:

- Chapter 1, Introduction
- Chapter 2, Stratix Architecture
- Chapter 3, Configuration & Testing
- Chapter 4, DC & Switching Characteristics
- Chapter 5, Reference & Ordering Information

Revision History

The table below shows the revision history for Chapters 1 through 5.

Chapter	Date/Version	Changes Made
1	July 2005, v3.2	Minor content changes.
	September 2004, v3.1	• Updated Table 1–6 on page 1–5.
	April 2004, v3.0	 Main section page numbers changed on first page. Changed PCI-X to PCI-X 1.0 in "Features" on page 1–2. Global change from SignalTap to SignalTap II. The DSP blocks in "Features" on page 1–2 provide dedicated implementation of multipliers that are now "faster than 300 MHz."
	January 2004, v2.2	Updated -5 speed grade device information in Table 1-6.
	October 2003, v2.1	Add -8 speed grade device information.
	July 2003, v2.0	Format changes throughout chapter.

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Chapter	Date/Version	Changes Made
2	July 2005 v3.2	 Added "Clear Signals" section. Updated "Power Sequencing & Hot Socketing" section. Format changes.
	September 2004, v3.1	 Updated fast regional clock networks description on page 2–73. Deleted the word preliminary from the "specification for the maximum time to relock is 100 µs" on page 2–90. Added information about differential SSTL and HSTL outputs in "External Clock Outputs" on page 2–92. Updated notes in Figure 2–55 on page 2–93. Added information about <i>m</i> counter to "Clock Multiplication & Division" on page 2–101. Updated Note 1 in Table 2–58 on page 2–101. Updated description of "Clock Multiplication & Division" on page 2–88. Updated Table 2–22 on page 2–102. Added references to AN 349 and AN 329 to "External RAM Interfacing" on page 2–115. Table 2–25 on page 2–116: updated the table, updated Notes 3 and 4. Notes 4, 5, and 6, are now Notes 5, 6, and 7, respectively. Updated Table 2–26 on page 2–117. Added information about PCI Compliance to page 2–120. Table 2–32 on page 2–126: updated the table and deleted Note 1. Updated reference to device pin-outs now being available on the web on page 2–130. Added Notes 4 and 5 to Table 2–36 on page 2–130. Updated Note 3 in Table 2–37 on page 2–131. Updated Note 5 in Table 2–41 on page 2–135.
	April 2004, v3.0	 Added note 3 to rows 11 and 12 in Table 2–18. Deleted "Stratix and Stratix GX Device PLL Availability" table. Added I/O standards row in Table 2–28 that support max and min strength. Row clk [1,3,8,10] was removed from Table 2–30. Added checkmarks in Enhanced column for LVPECL, 3.3-V PCML, LVDS, and HyperTransport technology rows in Table 2–32. Removed the Left and Right I/O Banks row in Table 2–34. Changed RCLK values in Figures 2–50 and 2–51. External RAM Interfacing section replaced.
	November 2003, v2.2	 Added 672-pin BGA package information in Table 2–37. Removed support for series and parallel on-chip termination. Termination Technology renamed differential on-chip termination. Updated the number of channels per PLL in Tables 2-38 through 2-42. Updated Figures 2–65 and 2–67.
	October 2003, v2.1	 Updated DDR I information. Updated Table 2–22. Added Tables 2–25, 2–29, 2–30, and 2–72. Updated Figures 2–59, 2–65, and 2–67. Updated the Lock Detect section.

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Chapter	Date/Version	Changes Made
2	July 2003, v2.0	 Added reference on page 2-73 to Figures 2-50 and 2-51 for RCLK connections. Updated ranges for EPLL post-scale and pre-scale dividers on page 2-85. Updated PLL Reconfiguration frequency from 25 to 22 MHz on page 2-87. New requirement to assert are set signal each PLL when it has to reacquire lock on either a new clock after loss of lock (page 2-96). Updated max input frequency for CLK [1,3,8,10] from 462 to 500, Table 2-24. Renamed impedance matching to series termination throughout. Updated naming convention for DQS pins on page 2-112 to match pin tables. Added DDR SDRAM Performance Specification on page 2-117. Added external reference resistor values for terminator technology (page 2-136). Added Terminator Technology Specification on pages 2-137 and 2-138. Updated Tables 2-45 to 2-49 to reflect PLL cross-bank support for high speed differential channels at full speed. Wire bond package performance specification for "high" speed channels was increased to 624 Mbps from 462 Mbps throughout chapter.
3	July 2005, v1.3	 Updated "Operating Modes" section. Updated "Temperature Sensing Diode" section. Updated "IEEE Std. 1149.1 (JTAG) Boundary-Scan Support" section. Updated "Configuration" section.
	January 2005, v1.2	Updated limits for JTAG chain of devices.
	September 2004, v1.1	 Added new section, "Stratix Automated Single Event Upset (SEU) Detection" on page 3–12. Updated description of "Custom-Built Circuitry" on page 3–13.
	April 2003, v1.0	No new changes in Stratix Device Handbook v2.0.
4	January 2006, v3.4	Added Table 4–135.
	July 2005, v3.3	 Updated Tables 4–6 and 4–30. Updated Tables 4–103 through 4–108. Updated Tables 4–114 through 4–124. Updated Table 4–129. Added Table 4–130.

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Chapter	Date/Version	Changes Made
4	January 2005, 3.2	Updated rise and fall input values.
	September 2004, v3.1	 Updated Note 3 in Table 4–8 on page 4–4. Updated Table 4–10 on page 4–6. Updated Table 4–20 on page 4–12 through Table 4–23 on page 4–13. Added rows V_{IL(AC)} and V_{IH(AC)} to each table. Updated Table 4–26 on page 4–14 through Table 4–29 on page 4–15. Updated Table 4–31 on page 4–16. Updated Table 4–36 on page 4–20. Added signals t_{OUTCO}, T_{XZ}, and T_{ZX} to Figure 4–4 on page 4–33. Added rows t_{M512CLKENSU} and t_{M512CLKENH} to Table 4–40 on page 4–24. Added rows t_{M4CLKENSU} and t_{M4CLKENH} to Table 4–41 on page 4–24. Updated Note 2 in Table 4–54 on page 4–35. Added rows t_{MRAMCLKENSU} and t_{MRAMCLKENH} to Table 4–42 on page 4–25. Updated Table 4–46 on page 4–29. Updated Table 4–47 on page 4–29.

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Chapter	Date/Version	Changes Made
4	Date/Version	 Table 4–48 on page 4–30: added rows t_{M512CLKSENSU} and t_{M512CLKENH}, and updated symbol names. Updated power-up current (ICCINT) required to power a Stratix device on page 4–17. Updated Table 4–37 on page 4–22 through Table 4–43 on page 4–27. Table 4–49 on page 4–31: added rows t_{M4KCLKENSU}, t_{M4KCLKENH}, t_{M4KBESU}, and t_{M4KBEH}, deleted rows t_{M4KRADDRASU} and t_{M4KRADDRH}, and updated symbol names. Table 4–50 on page 4–31: added rows t_{MRAMDDRASU} and t_{M4KRADDRH}, and updated symbol names. Table 4–52 on page 4–34: updated table, deleted "Conditions" column, and added rows t_{X2} and t_{Zx}. Table 4–52 on page 4–34: updated table, deleted "Conditions" column, and added rows t_{X2} and t_{Zx}. Table 4–53 on page 4–34: updated table and added rows t_{X2PLL} and t_{XXPLL}. Updated Note 2 in Table 4–53 on page 4–34. Table 4–54 on page 4–35: updated table, deleted "Conditions" column, and added rows t_{X2PLL} and t_{XXPLL}. Updated Note 2 in Table 4–54 on page 4–35. Deleted Note 2 from Table 4–55 on page 4–36 through Table 4–66 on page 4–41. Updated Table 4–55 on page 4–36 through Table 4–96 on page 4–56. Added rows T_{X2}, T_{X2}, T_{X2PLL}, and T_{ZXPLL}. Added Note 1 from Table 4–67 on page 4–62. Deleted Note 1 from Table 4–67 on page 4–42 through Table 4–84 on page 4–50. Added new section "I/O Timing Measurement Methodology" on page 4–50. Deleted Note 2 from Table 4–85 on page 4–51 through Table 4–84 on page 4–56. Added Note 4 to Table 4–101 on page 4–62. Deleted Note 2 from Table 4–85 on page 4–51 through Table 4–84 on page 4–56. Added Note 4 to Table 4–101 on page 4–62. Table 4–102 on page 4–64: updated table and added Note 4. Updated description of "External I/O Delay Parameters" on page 4–66. Added Note 1 to Table 4–109 on page 4–73 and Table 4–110 on page 4–74.
		Added Note 1 to Table 4–109 on page 4–73 and Table 4–110 on

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Chapter	Date/Version	Changes Made
4		 Updated Table 4–123 on page 4–85 through Table 4–126 on page 4–92. Updated Note 3 in Table 4–123 on page 4–85. Table 4–125 on page 4–88: moved to correct order in chapter, and updated table. Updated Table 4–126 on page 4–92. Updated Table 4–127 on page 4–94. Updated Table 4–128 on page 4–95.
	April 2004, v3.0	 Table 4–129 on page 4–96: updated table and added Note 10. Updated Table 4–131 and Table 4–132 on page 4–100. Updated Table 4–110 on page 4–74. Updated Table 4–123 on page 4–85. Updated Table 4–124 on page 4–87. through Table 4–126 on page 4–92. Added Note 10 to Table 4–129 on page 4–96. Moved Table 4–127 on page 4–94 to correct order in the chapter. Updated Table 4–131 on page 4–100 through Table 4–132 on page 4–100. Deleted t_{XZ} and t_{ZX} from Figure 4–4. Waveform was added to Figure 4–6. The minimum and maximum duty cycle values in Note 3 of Table 4–8 were moved to a new Table 4–9. Changes were made to values in SSTL-3 Class I and II rows in Table 4–17. Note 1 was added to Table 4–34. Added t_{SU_R} and t_{SU_C} rows in Table 4–38. Changed Table 4–55 title from "EP1S10 Column Pin Fast Regional Clock External I/O Timing Parameters" to "EP1S10 External I/O Timing on Column Pins Using Fast Regional Clock Networks." Changed values in Tables 4–46, 4–48 to 4–51, 4–128, and 4–131. Added t_{ARESET} row in Tables 4–127 to 4–132. Deleted -5 Speed Grade column in Tables 4–117 to 4–119 and 4–122 to 4–123. Fixed differential waveform in Figure 4–1. Added "Definition of I/O Skew" section. Added t_{SU} and t_{CO_C} rows and made changes to values in t_{PRE} and t_{CLKHL} rows in Table 4–46. Values changed in the t_{MAKCLKHL} row in Table 4–47. Values changed in the t_{MMAKCLKHL} row in Table 4–55 through 4–96. Table 4–51 to "Internal Timing Parameters" section. The timing information is preliminary in Tables 4–55 through 4–96. Table 4–111 was separated into 3 tables: Tables 4–111 to 4–113.
	November 2003, v2.2	Updated Tables 4–127 through 4–129.

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Chapter	Date/Version	Changes Made
4	October 2003, v2.1	 Added -8 speed grade information. Updated performance information in Table 4–36. Updated timing information in Tables 4–55 through 4–96. Updated delay information in Tables 4–103 through 4–108. Updated programmable delay information in Tables 4–100 and 4–103.
	July 2003, v2.0	 Updated clock rates in Tables 4–114 through 4–123. Updated speed grade information in the introduction on page 4-1. Corrected figures 4-1 & 4-2 and Table 4-9 to reflect how VID and VOD are specified. Added note 6 to Table 4-32. Updated Stratix Performance Table 4-35. Updated EP1S60 and EP1S80 timing parameters in Tables 4-82 to 4-93. The Stratix timing models are final for all devices. Updated Stratix IOE programmable delay chains in Tables 4-100 to 4-101. Added single-ended I/O standard output pin delay adders for loading in Table 4-102. Added spec for FPLL[107]CLK pins in Tables 4-104 and 4-107. Updated high-speed I/O specification for J=2 in Tables 4-114 and 4-115. Updated EPLL specification and fast PLL specification in Tables 4-116 to 4-120.
5	September 2004, v2.1	 Updated reference to device pin-outs on page 5–1 to indicate that device pin-outs are no longer included in this manual and are now available on the Altera web site.
	April 2003, v1.0	No new changes in Stratix Device Handbook v2.0.

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1. Introduction



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Introduction

The Stratix® family of FPGAs is based on a 1.5-V, 0.13- μ m, all-layer copper SRAM process, with densities of up to 79,040 logic elements (LEs) and up to 7.5 Mbits of RAM. Stratix devices offer up to 22 digital signal processing (DSP) blocks with up to 176 (9-bit × 9-bit) embedded multipliers, optimized for DSP applications that enable efficient implementation of high-performance filters and multipliers. Stratix devices support various I/O standards and also offer a complete clock management solution with its hierarchical clock structure with up to 420-MHz performance and up to 12 phase-locked loops (PLLs).

The following shows the main sections in the Stratix Device Family Data Sheet:

Section	Page	
Features	1–2	
Functional Description	2–1	
Logic Array Blocks		
Logic Elements		
MultiTrack Interconnect		
TriMatrix Memory		
Digital Signal Processing Block		
PLLs & Clock Networks		
I/O Structure		
High-Speed Differential I/O Support		
Power Sequencing & Hot Socketing	2–140	
IEEE Std. 1149.1 (JTAG) Boundary-Scan Support	3–1	
SignalTap II Embedded Logic Analyzer		
Configuration		
Temperature Sensing Diode		
Operating Conditions	4–1	
Power Consumption		
Timing Model		
Software	5–1	
Device Pin-Outs		
Ordering Information		

Features

The Stratix family offers the following features:

- 10,570 to 79,040 LEs; see Table 1–1
- Up to 7,427,520 RAM bits (928,440 bytes) available without reducing logic resources
- TriMatrix[™] memory consisting of three RAM block sizes to implement true dual-port memory and first-in first-out (FIFO) buffers
- High-speed DSP blocks provide dedicated implementation of multipliers (faster than 300 MHz), multiply-accumulate functions, and finite impulse response (FIR) filters
- Up to 16 global clocks with 22 clocking resources per device region
- Up to 12 PLLs (four enhanced PLLs and eight fast PLLs) per device provide spread spectrum, programmable bandwidth, clock switchover, real-time PLL reconfiguration, and advanced multiplication and phase shifting
- Support for numerous single-ended and differential I/O standards
- High-speed differential I/O support on up to 116 channels with up to 80 channels optimized for 840 megabits per second (Mbps)
- Support for high-speed networking and communications bus standards including RapidIO, UTOPIA IV, CSIX, HyperTransport™ technology, 10G Ethernet XSBI, SPI-4 Phase 2 (POS-PHY Level 4), and SFI-4
- Differential on-chip termination support for LVDS
- Support for high-speed external memory, including zero bus turnaround (ZBT) SRAM, quad data rate (QDR and QDRII) SRAM, double data rate (DDR) SDRAM, DDR fast cycle RAM (FCRAM), and single data rate (SDR) SDRAM
- Support for 66-MHz PCI (64 and 32 bit) in -6 and faster speed-grade devices, support for 33-MHz PCI (64 and 32 bit) in -8 and faster speed-grade devices
- Support for 133-MHz PCI-X 1.0 in -5 speed-grade devices
- Support for 100-MHz PCI-X 1.0 in -6 and faster speed-grade devices
- Support for 66-MHz PCI-X 1.0 in -7 speed-grade devices
- Support for multiple intellectual property megafunctions from Altera MegaCore® functions and Altera Megafunction Partners Program (AMPPSM) megafunctions
- Support for remote configuration updates

Table 1–1. Stratix Device Features — EP1S10, EP1S20, EP1S25, EP1S30						
Feature	EP1S10	EP1S20	EP1S25	EP1S30		
LEs	10,570	18,460	25,660	32,470		
M512 RAM blocks (32 × 18 bits)	94	194	224	295		
M4K RAM blocks (128 × 36 bits)	60	82	138	171		
M-RAM blocks (4K × 144 bits)	1	2	2	4		
Total RAM bits	920,448	1,669,248	1,944,576	3,317,184		
DSP blocks	6	10	10	12		
Embedded multipliers (1)	48	80	80	96		
PLLs	6	6	6	10		
Maximum user I/O pins	426	586	706	726		

Table 1–2. Stratix Device Features — EP1S40, EP1S60, EP1S80						
Feature	EP1S40	EP1S60	EP1S80			
LEs	41,250	57,120	79,040			
M512 RAM blocks (32 × 18 bits)	384	574	767			
M4K RAM blocks (128 × 36 bits)	183	292	364			
M-RAM blocks (4K × 144 bits)	4	6	9			
Total RAM bits	3,423,744	5,215,104	7,427,520			
DSP blocks	14	18	22			
Embedded multipliers (1)	112	144	176			
PLLs	12	12	12			
Maximum user I/O pins	822	1,022	1,238			

Note to Tables 1–1 and 1–2:

⁽¹⁾ This parameter lists the total number of 9×9 -bit multipliers for each device. For the total number of 18×18 -bit multipliers per device, divide the total number of 9×9 -bit multipliers by 2. For the total number of 36×36 -bit multipliers per device, divide the total number of 9×9 -bit multipliers by 8.

Stratix devices are available in space-saving FineLine BGA® and ball-grid array (BGA) packages (see Tables 1–3 through 1–5). All Stratix devices support vertical migration within the same package (for example, you can migrate between the EP1S10, EP1S20, and EP1S25 devices in the 672-pin BGA package). Vertical migration means that you can migrate to devices whose dedicated pins, configuration pins, and power pins are the same for a given package across device densities. For I/O pin migration across densities, you must cross-reference the available I/O pins using the device pin-outs for all planned densities of a given package type to identify which I/O pins are migrational. The Quartus® II software can automatically cross reference and place all pins except differential pins for migration when given a device migration list. You must use the pin-outs for each device to verify the differential placement migration. A future version of the Quartus II software will support differential pin migration.

Table 1–3. Stratix Package Options & I/O Pin Counts								
Device	672-Pin BGA	956-Pin BGA	484-Pin FineLine BGA	672-Pin FineLine BGA	780-Pin FineLine BGA	1,020-Pin FineLine BGA	1,508-Pin FineLine BGA	
EP1S10	345		335	345	426			
EP1S20	426		361	426	586			
EP1S25	473			473	597	706		
EP1S30		683			597	726		
EP1S40		683			615	773	822	
EP1S60		683				773	1,022	
EP1S80		683				773	1,203	

Note to Table 1-3:

⁽¹⁾ All I/O pin counts include 20 dedicated clock input pins (clk[15..0]p, clk0n, clk2n, clk9n, and clk11n) that can be used for data inputs.

Table 1–4. Stratix BGA Package Sizes					
Dimension	672 Pin	956 Pin			
Pitch (mm)	1.27	1.27			
Area (mm²)	1,225	1,600			
Length × width (mm × mm)	35 × 35	40 × 40			

Table 1–5. Stratix FineLine BGA Package Sizes							
Dimension 484 Pin 672 Pin 780 Pin 1,020 Pin							
Pitch (mm)	1.00	1.00	1.00	1.00	1.00		
Area (mm²)	529	729	841	1,089	1,600		
$\begin{array}{c} \text{Length} \times \text{width} \\ \text{(mm} \times \text{mm)} \end{array}$	23 × 23	27 × 27	29 × 29	33 × 33	40 × 40		

Stratix devices are available in up to four speed grades, -5, -6, -7, and -8, with -5 being the fastest. Table 1–6 shows Stratix device speed-grade offerings.

Table 1–6. Stratix Device Speed Grades								
Device	672-Pin BGA	956-Pin BGA	484-Pin FineLine BGA	672-Pin FineLine BGA	780-Pin FineLine BGA	1,020-Pin FineLine BGA	1,508-Pin FineLine BGA	
EP1S10	-6, -7		-5, -6, -7	-6, -7	-5, -6, -7			
EP1S20	-6, -7		-5, -6, -7	-6, -7	-5, -6, -7			
EP1S25	-6, -7			-6, -7, -8	-5, -6, -7	-5, -6, -7		
EP1S30		-5, -6, -7			-5, -6, -7, -8	-5, -6, -7		
EP1S40		-5, -6, -7			-5, -6, -7, -8	-5, -6, -7	-5, -6, -7	
EP1S60		-6, -7				-5, -6, -7	-6, -7	
EP1S80		-6, -7				-5, -6, -7	-5, -6, -7	

2. Stratix Architecture

\$51002-3.2

Functional Description

Stratix® devices contain a two-dimensional row- and column-based architecture to implement custom logic. A series of column and row interconnects of varying length and speed provide signal interconnects between logic array blocks (LABs), memory block structures, and DSP blocks.

The logic array consists of LABs, with 10 logic elements (LEs) in each LAB. An LE is a small unit of logic providing efficient implementation of user logic functions. LABs are grouped into rows and columns across the device.

M512 RAM blocks are simple dual-port memory blocks with 512 bits plus parity (576 bits). These blocks provide dedicated simple dual-port or single-port memory up to 18-bits wide at up to 318 MHz. M512 blocks are grouped into columns across the device in between certain LABs.

M4K RAM blocks are true dual-port memory blocks with 4K bits plus parity (4,608 bits). These blocks provide dedicated true dual-port, simple dual-port, or single-port memory up to 36-bits wide at up to 291 MHz. These blocks are grouped into columns across the device in between certain LABs.

M-RAM blocks are true dual-port memory blocks with 512K bits plus parity (589,824 bits). These blocks provide dedicated true dual-port, simple dual-port, or single-port memory up to 144-bits wide at up to 269 MHz. Several M-RAM blocks are located individually or in pairs within the device's logic array.

Digital signal processing (DSP) blocks can implement up to either eight full-precision 9×9 -bit multipliers, four full-precision 18×18 -bit multipliers, or one full-precision 36×36 -bit multiplier with add or subtract features. These blocks also contain 18-bit input shift registers for digital signal processing applications, including FIR and infinite impulse response (IIR) filters. DSP blocks are grouped into two columns in each device.

Each Stratix device I/O pin is fed by an I/O element (IOE) located at the end of LAB rows and columns around the periphery of the device. I/O pins support numerous single-ended and differential I/O standards. Each IOE contains a bidirectional I/O buffer and six registers for registering input, output, and output-enable signals. When used with